

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	3127	(inspect\$6 or detect\$6 or determin\$6) adj6 ((defect\$3 or flaw\$2) near6 (wafer\$2 or chip\$2))	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:20
L2	524	((image\$2 or imaging) adj8 (wafer\$2 or chip\$2)) near12 (edge\$2 or perimeter\$2)	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:22
L3	294	((store\$3 or storage\$3 or storing) adj6 (data\$5 or inform\$6)) near22 ((defect\$3 or flaw\$2) near6 (wafer\$2 or chip\$2 or edge\$3))	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:24
L4	6	2 and 3	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:30
L5	1	"6576919".PN.	USPAT; USOCR	OR	ON	2005/06/25 10:28
L6	1	"6249342".PN.	USPAT; USOCR	OR	ON	2005/06/25 10:28
L7	1	"5684599".PN.	USPAT; USOCR	OR	ON	2005/06/25 10:29
L8	1	"5438209".PN.	USPAT; USOCR	OR	ON	2005/06/25 10:29
L9	1	"4887904".PN.	USPAT; USOCR	OR	ON	2005/06/25 10:30
L10	39	1 and 2	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:35
L11	121	(image\$2 or imaging) adj6 ((edge\$2 adj4 wafer\$2))	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:36
L12	2	3 and 11	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:37
L13	11	1 and 11	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:38
L14	6285	(250/559.\$7.ccls.)	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:39
L15	3	11 and 14	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:39
L16	1841	(250/221.ccls.)	USPAT; EPO; JPO; DERWENT	OR	ON	2005/06/25 10:39